Application/Control No. Applicant(s)/Patent Under Reexamination 10/614,951 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2182 Tanh Q. Nguyen **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,907,048 B1	06-2005	Treadaway et al.	370/474
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	D	US-			
	E	US-			
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